

<b>Notice of References Cited</b>	Application/Control No. 10/757,990	Applicant(s)/Patent Under Reexamination OH ET AL.	
	Examiner Rita R. Patel	Art Unit 1746	Page 1 of 1

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*	B	US-5,461,887	10-1995	VonPless, Douglas J.	68/18F
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**NON-PATENT DOCUMENTS**

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